



Samsung Electronics Co., Ltd.
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SAR DATA REUSE

- FCC ID : A3LSMN985F1

To Whom it May Concern

We attest the following regarding FCC ID A3LSMN985F1. The FCC OET-approved SAR test data reuse plan is contingent on specific similarities between the parent model and variant model. We attest to those conditions as follows:

1. The variant model FCC ID: A3LSMN985F1 as compared to the reference device FCC ID A3LSMN986B1:
 - a. is equipped with the same s/w and h/w for the bands enabled for transmission on the variant device (circuit changes only affect the bands / modes that are not supported on the variant model)
 - b. utilizes the same, or smaller, transmitter frequency ranges
 - c. utilizes the same modulation type
 - d. utilizes the same power-control sensor scheme

2. The variant device materials, form factor, and PCB layout are not changed from the reference device

3. The position of the components on the PCB is not changed beyond the components depopulated as noted in 2a above.

Should you have any questions or comments concerning the above, please contact the undersigned.

Sincerely,

A handwritten signature in black ink, appearing to read "Jenni Chun".

Ms. Jenni Chun
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